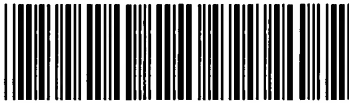


Search Notes

Application/Control No.

10/603,816

Examiner

Joon H. Hwang

Applicant(s)/Patent under
Reexamination

HIGASHIURA ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See search history printout(s)	12/1/2006	JH